


<b>Search Notes</b>  	<b>Application/Control No.</b>  10625909	<b>Applicant(s)/Patent Under Reexamination</b>  STURA ET AL.
	<b>Examiner</b>  Justin Y Lee	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
455	all	7/14/2008	/JL/
455	405, 406, 408, 414.1	6/1/2009	/JL/
379	114.1	6/1/2009	/JL/

SEARCH NOTES			
Search Notes		Date	Examiner
East		7/14/2008	/JL/
Inventor Search		7/14/2008	/JL/
Consulted withDuc Nguyen (SPE 2618)		6/1/2009	/JL/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
455	405, 406, 408, 414.1	6/1/2009	/JL/
379	114.1	6/1/2009	/JL/

/Justin Y Lee/  
Examiner,Art Unit 2617